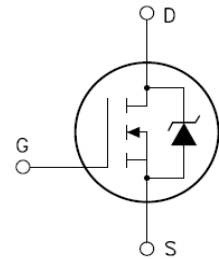


Main Product Characteristics:

V_{DSS}	60V
$R_{DS(on)}$	67m Ω (typ.)
I_D	4A


SOT-223

Marking and pin Assignment

Schematic diagram
Features and Benefits:

- Advanced MOSFET process technology
- Special designed for DC-DC and DC-AC converters, load switching and general purpose applications
- Ultra low on-resistance with low gate charge
- Fast switching and reverse body recovery
- 175°C operating temperature


Description:

It utilizes the latest processing techniques to achieve the high cell density and reduces the on-resistance with high repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in DC-DC and DC-AC converters and a wide variety of other applications.

Absolute max Rating:

Symbol	Parameter	Max.	Units
I_D @ TC = 25°C	Continuous Drain Current, V_{GS} @ 10V ^①	4	A
I_D @ TC = 100°C	Continuous Drain Current, V_{GS} @ 10V ^①	3	
I_{DM}	Pulsed Drain Current ^②	16	
P_D @TC = 25°C	Power Dissipation ^③	3.3	W
V_{DS}	Drain-Source Voltage	60	V
V_{GS}	Gate-to-Source Voltage	± 20	V
E_{AS}	Single Pulse Avalanche Energy @ L=0.3mH	15	mJ
I_{AS}	Avalanche Current @ L=0.3mH	10	A
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to +175	°C


Thermal Resistance

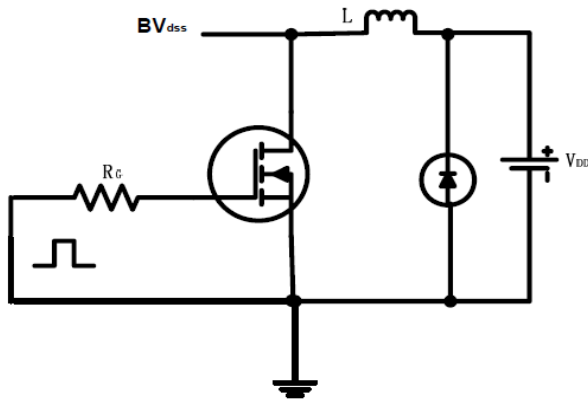
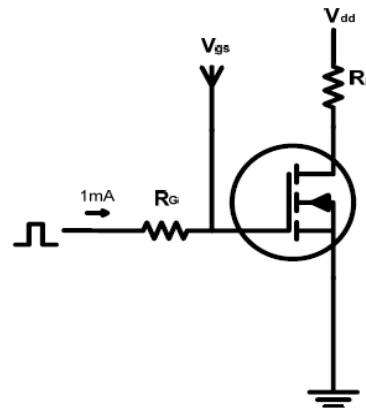
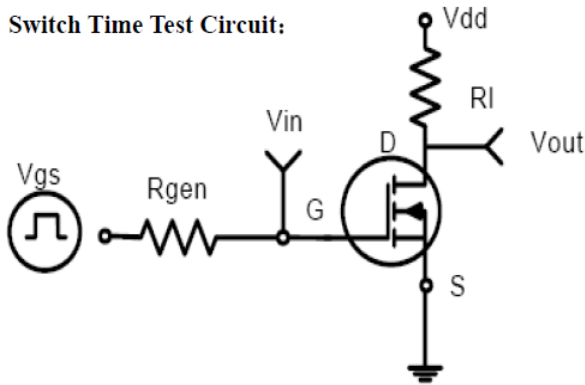
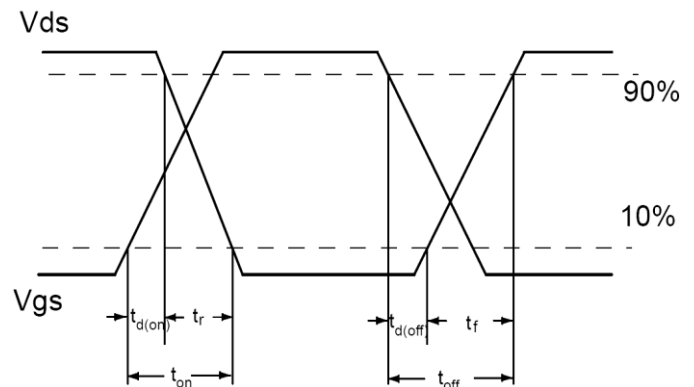
Symbol	Characterizes	Typ.	Max.	Units
$R_{\theta JA}$	Junction-to-ambient (t ≤ 10s) ^④	—	38	°C/W
	Junction-to-Ambient (PCB mounted, steady-state) ^④	—	35	°C/W

Electrical Characterizes @ $T_A=25^{\circ}\text{C}$ unless otherwise specified

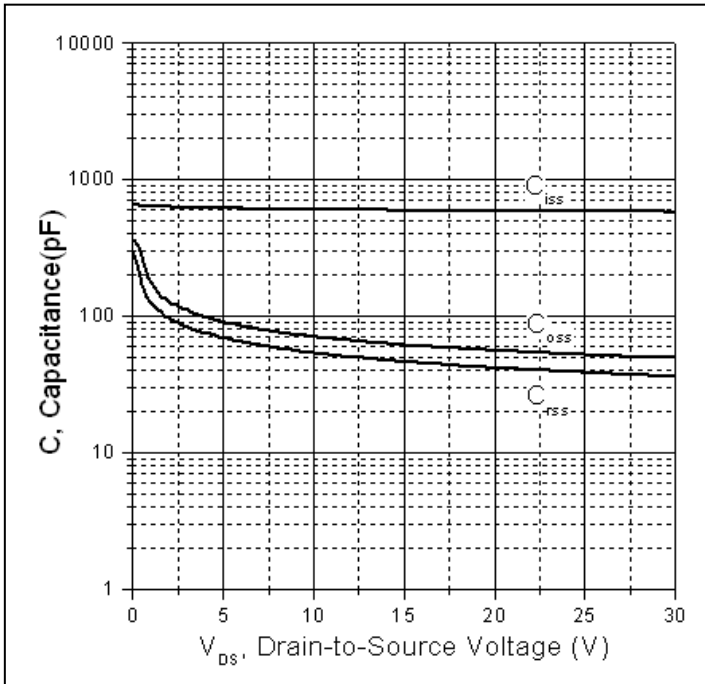
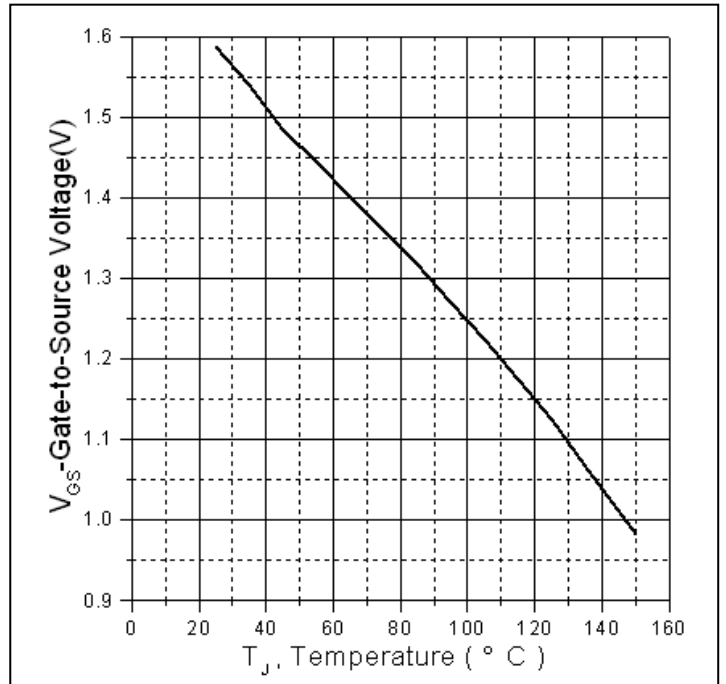
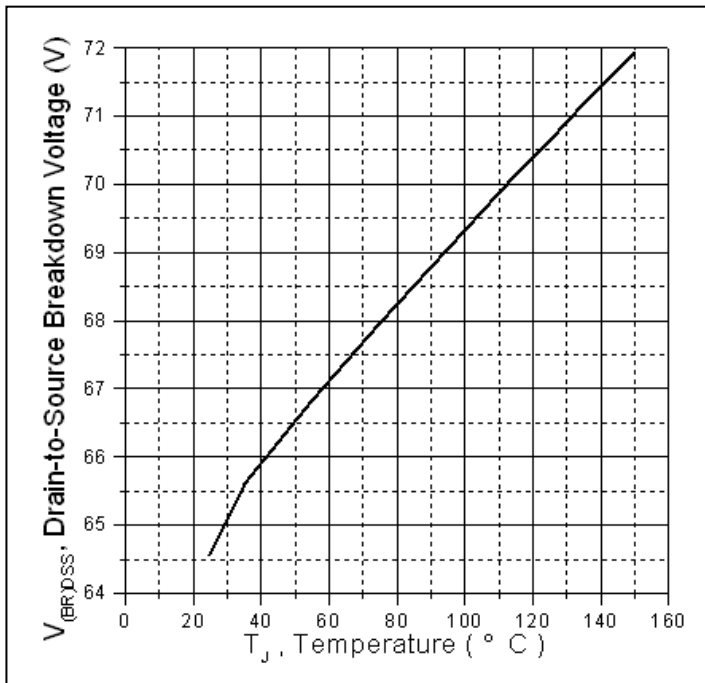
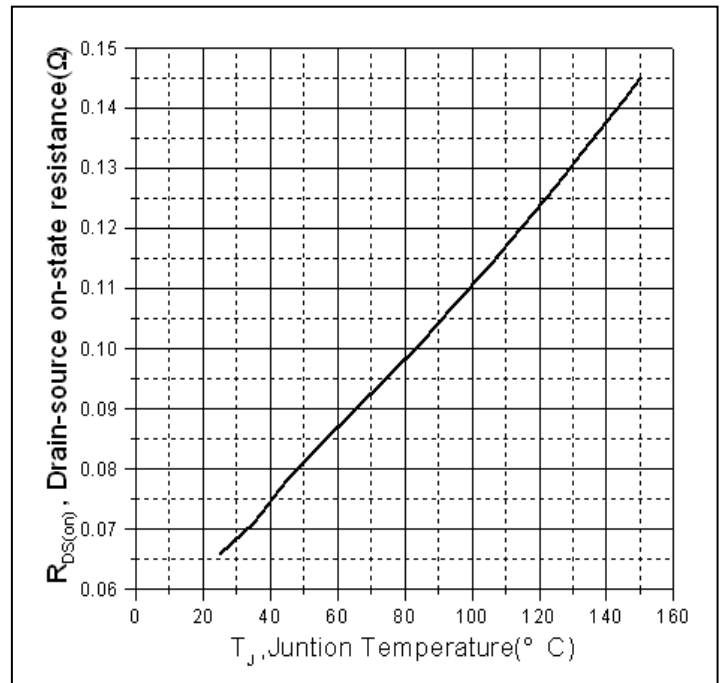
Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source breakdown voltage	60	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$R_{DS(on)}$	Static Drain-to-Source on-resistance	—	67	100	m Ω	$V_{GS}=10V, I_D = 1.5A$
		—	76	115		$V_{GS}=5V, I_D = 1.5A$
$V_{GS(th)}$	Gate threshold voltage	1	—	2.5	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
I_{DSS}	Drain-to-Source leakage current	—	—	1	μA	$V_{DS} = 60V, V_{GS} = 0V$
		—	—	10		$T_J = 125^{\circ}\text{C}$
I_{GSS}	Gate-to-Source forward leakage	—	—	100	nA	$V_{GS} = 20V$
		—	—	-100		$V_{GS} = -20V$
g_{fs}	Forward Transconductance	1	—	—	S	$V_{DS} = 15V, I_D = 1.5A$
Q_g	Total gate charge	—	12	—	nC	$I_D = 4A,$ $V_{DS}=40V,$ $V_{GS} = 10V$
Q_{gs}	Gate-to-Source charge	—	3.5	—		
Q_{gd}	Gate-to-Drain("Miller") charge	—	3.7	—		
$t_{d(on)}$	Turn-on delay time	—	9.2	—	ns	$V_{GS}=10V, V_{DS}=25V,$ $R_{GEN}=50\Omega, I_D = 1.2A,$
t_r	Rise time	—	16.7	—		
$t_{d(off)}$	Turn-Off delay time	—	35.4	—		
t_f	Fall time	—	8.6	—		
C_{iss}	Input capacitance	—	582	—	pF	$V_{GS} = 0V$
C_{oss}	Output capacitance	—	49	—		$V_{DS} = 30V$
C_{rss}	Reverse transfer capacitance	—	36	—		$f = 1\text{MHz}$

Source-Drain Ratings and Characteristics

Symbol	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	4	A	MOSFET symbol showing the integral reverse p-n junction diode. 
I_{SM}	Pulsed Source Current (Body Diode)	—	—	16	A	
V_{SD}	Diode Forward Voltage	—	—	1.5	V	$I_S=4A, V_{GS}=0V$

Test circuits and Waveforms
EAS test circuits:

Gate charge test circuit:

Switch Time Test Circuit:

Switch Waveforms:

Notes:

- ① The maximum current rating is limited by bond-wires.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- ③ The power dissipation PD is based on max. junction temperature, using junction-to- ambient thermal resistance.
- ④ The value of $R_{\theta JA}$ is measured with the device mounted on 1in 2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ C$

Typical electrical and thermal characteristics

Figure 1: Typical Capacitance Vs. Drain-to-Source Voltage

Figure 2. Gate to source cut-off voltage

Figure 3. Drain-to-Source Breakdown Voltage Vs. Case Temperature

Figure 4: Normalized On-Resistance Vs. Case Temperature

Typical electrical and thermal characteristics

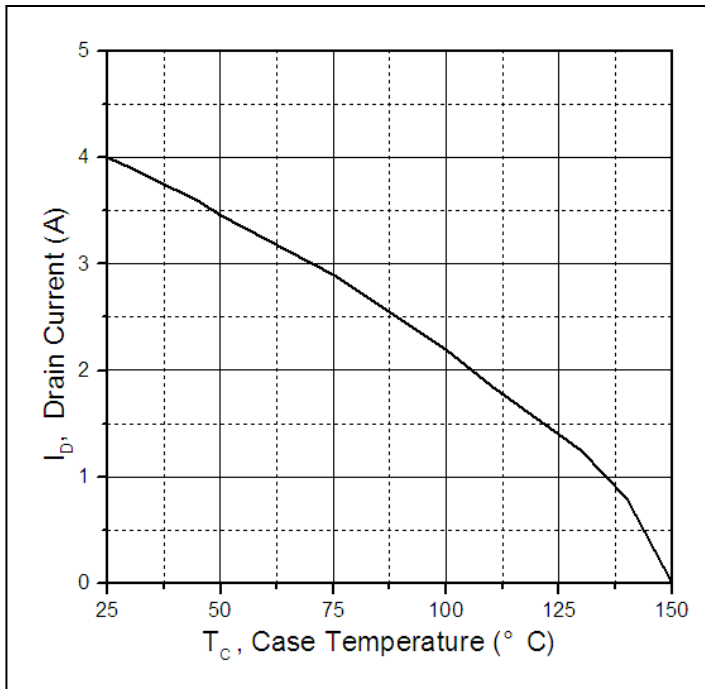


Figure 5. Maximum Drain Current Vs. Case Temperature

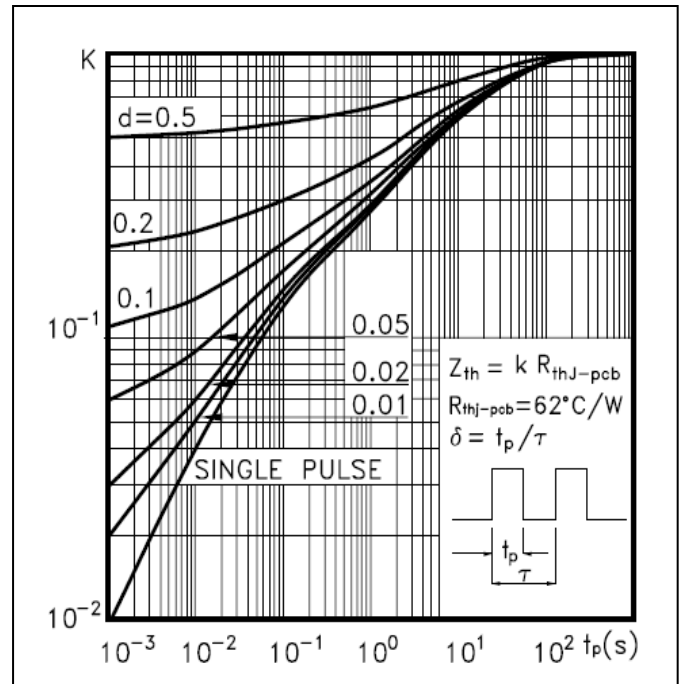
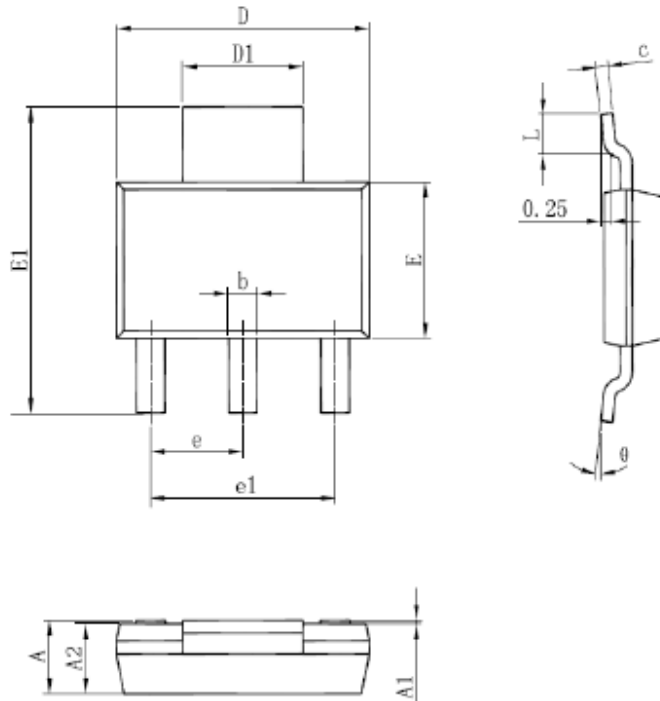


Figure 6. Maximum Effective Transient Thermal Impedance, Junction-to-Case

Mechanical Data:
SOT-223 Dimensions in Millimeters (UNIT: mm)


Symbol	Dimensions In Millimeters		Dimensions In Inches	
	Min	Max	Min	Max
A	1.520	1.800	0.060	0.071
A1	0.000	0.100	0.000	0.004
A2	1.500	1.700	0.059	0.067
b	0.660	0.820	0.026	0.032
c	0.250	0.350	0.010	0.014
D	6.200	6.400	0.244	0.252
D1	2.900	3.100	0.114	0.122
E	3.300	3.700	0.130	0.146
E1	6.830	7.070	0.269	0.278
e	2.300(BSC)		0.091(BSC)	
e1	4.500	4.700	0.177	0.185
L	0.900	1.150	0.035	0.045
θ	0°	10°	0°	10°

Notes:

- ① Dimensions are inclusive of plating
- ② Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 6 mils.
- ③ Dimension L is measured in gauge plane.
- ④ Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.

Ordering and Marking Information**Device Marking: SSF6072G5**

Package (Available)
SOT-223
Operating Temperature Range
C : -55 to 175°C

Devices per Unit

Package Type	Units/ Tube	Tubes/ Inner Box	Units/ Inner Box	Inner Boxes/ Carton Box	Units/ Carton Box
SOT-223	2500pcs	2pcs	5000pcs	8pcs	40000pcs

Reliability Test Program

Test Item	Conditions	Duration	Sample Size
High Temperature Reverse Bias(HTRB)	$T_j=125^{\circ}\text{C}$ or 150°C @ 80% of Max $V_{DSS}/V_{CES}/V_R$	168 hours 500 hours 1000 hours	3 lots x 77 devices
High Temperature Gate Bias(HTGB)	$T_j=125^{\circ}\text{C}$ or 150°C @ 100% of Max V_{GSS}	168 hours 500 hours 1000 hours	3 lots x 77 devices

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Customer Service**Worldwide Sales and Service:**

Sales@silikron.com

Technical Support:

Technical@silikron.com

Suzhou Silikron Semiconductor Corp.

Building 11A Suchun Industrial Square, 428# Xinglong Street, Suzhou P.R. China

TEL: (86-512) 62560688

FAX: (86-512) 65160705

E-mail: Sales@silikron.com